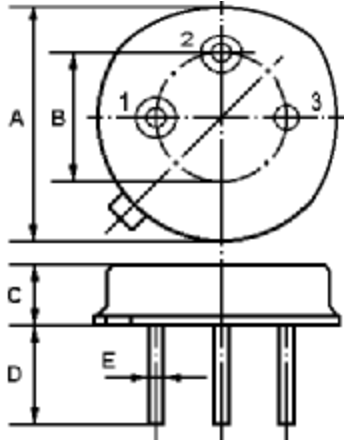


The **ACTQ868.3D/868.3/TO39** is a two-port, 180° surface-acoustic-wave (SAW) resonator in a low-profile metal **TO-39** case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at **868.300 MHz**.

1.Package Dimension (TO-39)

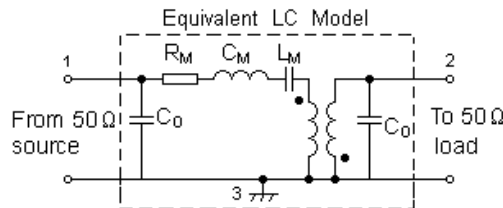


2.

Pin	Configuration
1	Input / Output
2	Output / Input
3	Case Ground

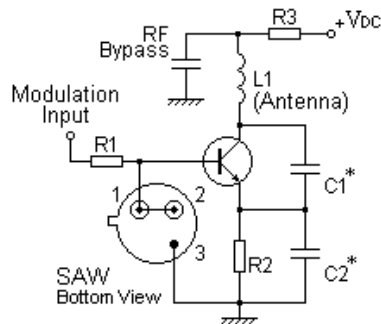
Dimension	Data (unit: mm)
A	9.30±0.20
B	5.08±0.10
C	3.40±0.20
D	3±0.20 / 5±0.20
E	0.45±0.20

3.Equivalent LC Model and Test Circuit

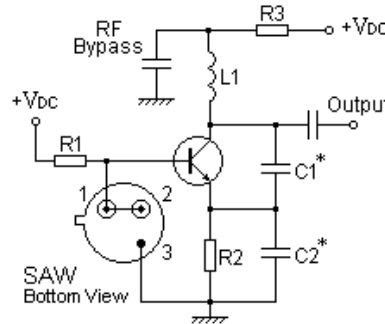


4.Typical Application Circuits

1) Low-Power Transmitter Application



2) Local Oscillator Application



In keeping with our ongoing policy of product evolution and improvement, the above specification is subject to change without notice.

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For quotations or further information please contact us at:

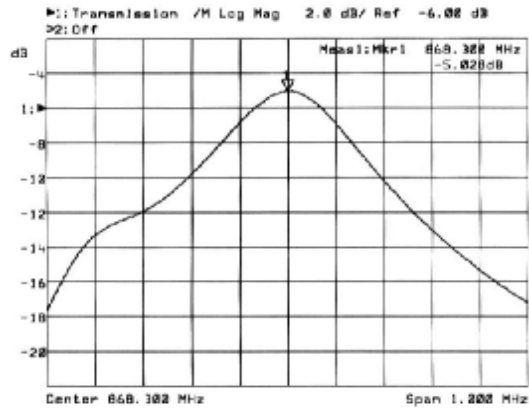
3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK

<http://www.actcrystals.com>

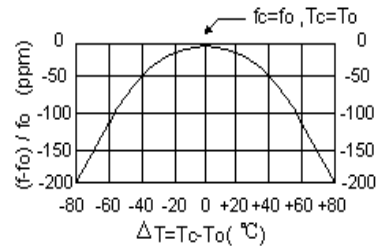
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5. Typical Frequency Response



6. Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include LC component temperature characteristics.

7. Performance

7-1. Maximum Ratings

Rating		Value	Unit
CW RF Power Dissipation	P	10	dBm
DC Voltage Between Any Two Pins	V_{DC}	±30	V
Storage Temperature Range	T_{stg}	-40 to +85	°C
Operating Temperature Range	T_A	-10 to +60	°C

7-2. Electronic Characteristics

Characteristic		Sym	Minimum	Typical	Maximum	Unit
Centre Frequency (+25°C)	Absolute Frequency	f_c	868.150		868.450	MHz
	Tolerance from 868.300 MHz	Δf_c		±150		kHz
Insertion Loss		IL		6.0	8.0	dB
Quality Factor	Unloaded Q	Q_U		5,400		
	50 Ω Loaded Q	Q_L		2,700		
Temperature Stability	Turnover Temperature	T_O	25		55	°C
	Turnover Frequency	f_o		f_c		kHz
	Frequency Temperature Coefficient	FTC		0.032		ppm/°C ²
Frequency Aging	Absolute Value during the First Year	$ f_A $		≤10		ppm/yr
DC Insulation Resistance Between Any Two Pins			1.0			MΩ
RF Equivalent RLC Model	Motional Resistance	R_M		99.5	151	Ω
	Motional Inductance	L_M		98.7819		μH
	Motional Capacitance	C_M		0.3405		fF
	Shunt Static Capacitance	C_O	2.20	2.50	2.80	pF

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i CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

1. The frequency f_c is the frequency of minimum IL with the resonator in the specified test fixture in a 50 Ω test system with VSWR \leq 1.2:1. Typically, $f_{OSCILLATOR}$ or $f_{TRANSMITTER}$ is less than the resonator f_c .
2. Unless noted otherwise, case temperature $T_C = +25^\circ\text{C} \pm 2^\circ\text{C}$.
3. Frequency aging is the change in f_c with time and is specified at $+65^\circ\text{C}$ or less. Aging may exceed the specification for prolonged temperatures above $+65^\circ\text{C}$. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
4. Turnover temperature, T_0 , is the temperature of maximum (or turnover) frequency, f_0 . The nominal frequency at any case temperature, T_C , may be calculated from: $f = f_0 [1 - FTC (T_0 - T_C)^2]$. Typically, *oscillator* T_0 is 20° less than the specified *resonator* T_0 .
5. This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C_0 is the measured static (non-motional) capacitance between either Pin 1 and ground or Pin 2 and ground. The measurement includes case parasitic capacitance.
6. Derived mathematically from one or more of the following directly measured parameters: f_c , IL, 3 dB bandwidth, f_c versus T_C , and C_0 .
7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

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